

Notice of References Cited

Application/Control No.

10/024,480

Applicant(s)/Patent Under

Examination

RUBINSTENN ET AL.

Examiner

Kimbhinh T. Nguyen

Art Unit

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NON-PATENT DOCUMENTS

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	U	Wu et al. "Skin aging Estimation by Facial Simulation", IEEE 1999, pages 210-219.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.